

SN54AHCT374, SN74AHCT374 OCTAL EDGE-TRIGGERED D-TYPE FLIP-FLOPS WITH 3-STATE OUTPUTS

SCLS241E – OCTOBER 1995 – REVISED JUNE 1997

- Inputs Are TTL-Voltage Compatible
- **EPIC™** (Enhanced-Performance Implanted CMOS) Process
- High Latch-Up Immunity Exceeds 250 mA Per JESD 17
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Package Options Include Plastic Small-Outline (DW), Shrink Small-Outline (DB), Thin Very Small-Outline (DGV), Thin Shrink Small-Outline (PW), and Ceramic Flat (W) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

description

The 'AHCT374 are octal edge-triggered D-type flip-flops that feature 3-state outputs designed specifically for driving highly capacitive or relatively low-impedance loads. This device is particularly suitable for implementing buffer registers, I/O ports, bidirectional bus drivers, and working registers.

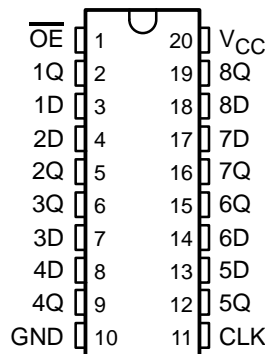
On the positive transition of the clock (CLK) input, the Q outputs are set to the logic levels of the data (D) inputs.

A buffered output-enable (\overline{OE}) input can be used to place the eight outputs in either a normal logic state (high or low logic levels) or the high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and the increased drive provide the capability to drive bus lines without interface or pullup components.

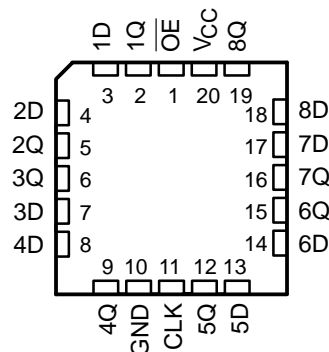
\overline{OE} does not affect internal operations of the flip-flop. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

The SN54AHCT374 is characterized for operation over the full military temperature range of -55°C to 125°C . The SN74AHCT374 is characterized for operation from -40°C to 85°C .

SN54AHCT374 . . . J OR W PACKAGE
SN74AHCT374 . . . DB, DGV, DW, N, OR PW PACKAGE
(TOP VIEW)



SN54AHCT374 . . . FK PACKAGE
(TOP VIEW)



FUNCTION TABLE
(each flip-flop)

INPUTS			OUTPUT Q
\overline{OE}	CLK	D	
L	\uparrow	H	H
L	\uparrow	L	L
L	H or L	X	Q_0
H	X	X	Z



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**TEXAS
INSTRUMENTS**

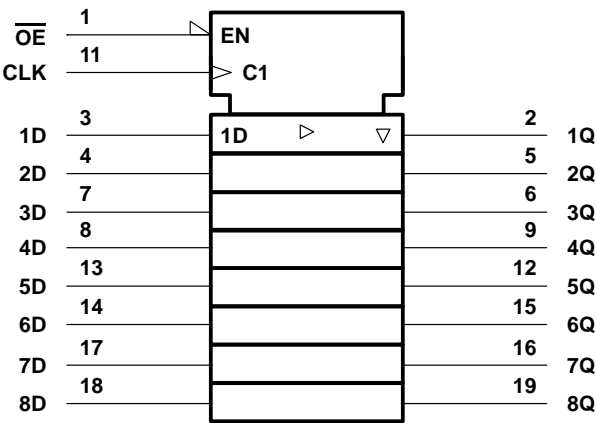
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WITH 3-STATE OUTPUTS

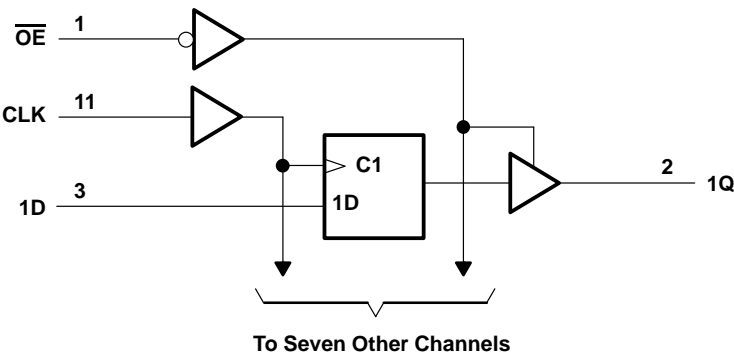
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logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage range, V_{CC}	–0.5 V to 7 V
Input voltage range, V_I (see Note 1)	–0.5 V to 7 V
Output voltage range, V_O (see Note 1)	–0.5 V to $V_{CC} + 0.5$ V
Input clamp current, I_{IK} ($V_I < 0$)	–20 mA
Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{CC}$)	±20 mA
Continuous output current, I_O ($V_O = 0$ to V_{CC})	±25 mA
Continuous current through V_{CC} or GND	±75 mA
Package thermal impedance, θ_{JA} (see Note 2): DB package	115°C/W
DGV package	146°C/W
DW package	97°C/W
N package	67°C/W
PW package	128°C/W
Storage temperature range, T_{stg}	–65°C to 150°C

‡ Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.
2. The package thermal impedance is calculated in accordance with JESD 51, except for through-hole packages, which use a trace length of zero.



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recommended operating conditions (see Note 3)

		SN54AHCT374		SN74AHCT374		UNIT
		MIN	MAX	MIN	MAX	
V _{CC}	Supply voltage	4.5	5.5	4.5	5.5	V
V _{IH}	High-level input voltage	2		2		V
V _{IL}	Low-level input voltage		0.8		0.8	V
V _I	Input voltage	0	5.5	0	5.5	V
V _O	Output voltage	0	V _{CC}	0	V _{CC}	V
I _{OH}	High-level output current		–8		–8	mA
I _{OL}	Low-level output current		8		8	mA
Δt/Δv	Input transition rise or fall rate		20		20	ns/V
T _A	Operating free-air temperature	–55	125	–40	85	°C

NOTE 3: Unused inputs must be held high or low to prevent them from floating.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V _{CC}	T _A = 25°C			SN54AHCT374		SN74AHCT374		UNIT
			MIN	TYP	MAX	MIN	MAX	MIN	MAX	
V _{OH}	I _{OH} = –50 μA	4.5 V	4.4	4.5		4.4		4.4		V
	I _{OH} = –8 mA		3.94			3.8		3.8		
V _{OL}	I _{OL} = 50 μA	4.5 V			0.1		0.1		0.1	V
	I _{OL} = 8 mA				0.36		0.44		0.44	
I _{OZ}	V _O = V _{CC} or GND, V _I = V _{IH} or V _{IL}	5.5 V			±0.25		±2.5		±2.5	μA
I _I	V _I = V _{CC} or GND	5.5 V			±0.1		±1		±1	μA
I _{CC}	V _I = V _{CC} or GND, I _O = 0	5.5 V			4		40		40	μA
ΔI _{CC} [†]	One input at 3.4 V, Other inputs at V _{CC} or GND	5.5 V			1.35		1.5		1.5	mA
C _i	V _I = V _{CC} or GND	5 V		4	10				10	pF
C _o	V _O = V _{CC} or GND	5 V		9						pF

[†] This is the increase in supply current for each input at one of the specified TTL voltage levels rather than 0 V or V_{CC}.

timing requirements over recommended operating free-air temperature range, V_{CC} = 5 V ± 0.5 V (unless otherwise noted) (see Figure 1)

		T _A = 25°C		SN54AHCT374		SN74AHCT374		UNIT
		MIN	MAX	MIN	MAX	MIN	MAX	
t _w	Pulse duration, CLK high or low	6.5		6.5		6.5		ns
t _{su}	Setup time, data before CLK [↑]	2.5		2.5		2.5		ns
t _h	Hold time, data after CLK [↑]	2.5		2.5		2.5		ns

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switching characteristics over recommended free-air temperature operating range,
 $V_{CC} = 5\text{ V} \pm 0.5\text{ V}$ (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	LOAD CAPACITANCE	SN54AHCT374					UNIT
				T _A = 25°C			MIN	MAX	
				MIN	TYP	MAX			
f _{max}			C _L = 15 pF*	90	140	80		MHz	
			C _L = 50 pF	85	130	75			
t _{PLH} *	CLK	Q	C _L = 15 pF	5.6	9.4	1	10.5	ns	
t _{PHL} *				5.6	9.4	1	10.5		
t _{PZH} *	$\overline{\text{OE}}$	Q	C _L = 15 pF	6.5	10.2	1	11.5	ns	
t _{PZL} *				6.5	10.2	1	11.5		
t _{PHZ} *	$\overline{\text{OE}}$	Q	C _L = 15 pF	6.2	10.2	1	11	ns	
t _{PLZ} *				6.2	10.2	1	11		
t _{PLH}	CLK	Q	C _L = 50 pF	6.4	10.4	1	11.5	ns	
t _{PHL}				6.4	10.4	1	11.5		
t _{PZH}	$\overline{\text{OE}}$	Q	C _L = 50 pF	7.3	11.2	1	12.5	ns	
t _{PZL}				7.3	11.2	1	12.5		
t _{PHZ}	$\overline{\text{OE}}$	Q	C _L = 50 pF	7	11.2	1	12	ns	
t _{PLZ}				7	11.2	1	12		

* On products compliant to MIL-PRF-38535, this parameter is ensured but not production tested.

switching characteristics over recommended free-air temperature operating range,
 $V_{CC} = 5\text{ V} \pm 0.5\text{ V}$ (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	LOAD CAPACITANCE	SN74AHCT374					UNIT
				T _A = 25°C			MIN	MAX	
				MIN	TYP	MAX			
f _{max}			C _L = 15 pF	90	140		80		MHz
			C _L = 50 pF	85	130		75		
t _{PLH}	CLK	Q	C _L = 15 pF		5.6	9.4	1	10.5	ns
t _{PHL}					5.6	9.4	1	10.5	
t _{PZH}	$\overline{\text{OE}}$	Q	C _L = 15 pF		6.5	10.2	1	11.5	ns
t _{PZL}					6.5	10.2	1	11.5	
t _{PHZ}	$\overline{\text{OE}}$	Q	C _L = 15 pF		6.2	10.2	1	11	ns
t _{PLZ}					6.2	10.2	1	11	
t _{PLH}	CLK	Q	C _L = 50 pF		6.4	10.4	1	11.5	ns
t _{PHL}					6.4	10.4	1	11.5	
t _{PZH}	$\overline{\text{OE}}$	Q	C _L = 50 pF		7.3	11.2	1	12.5	ns
t _{PZL}					7.3	11.2	1	12.5	
t _{PHZ}	$\overline{\text{OE}}$	Q	C _L = 50 pF		7	11.2	1	12	ns
t _{PLZ}					7	11.2	1	12	

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output-skew characteristics, $C_L = 50$ pF (see Note 4)

PARAMETER		V _{CC}	SN74AHCT374				UNIT
			T _A = 25°C		MIN	MAX	
			MIN	MAX			
t _{sk(o)}	Output skew	5 V ± 0.5 V	1		1	ns	

NOTE 4: Characteristics are determined during product characterization and ensured by design.

noise characteristics, $V_{CC} = 5$ V, $C_L = 50$ pF, $T_A = 25^\circ\text{C}$ (see Note 5)

PARAMETER	SN74AHCT374			UNIT
	MIN	TYP	MAX	
$V_{OL(P)}$ Quiet output, maximum dynamic V_{OL}		0.8	1.2	V
$V_{OL(V)}$ Quiet output, minimum dynamic V_{OL}		–0.8	–1.2	V
$V_{OH(V)}$ Quiet output, minimum dynamic V_{OH}	3.8			V
$V_{IH(D)}$ High-level dynamic input voltage	2			V
$V_{IL(D)}$ Low-level dynamic input voltage			0.8	V

NOTE 5: Characteristics are determined during product characterization and ensured by design for surface-mount packages only.

operating characteristics, $V_{CC} = 5$ V, $T_A = 25^\circ\text{C}$

PARAMETER	TEST CONDITIONS	TYP	UNIT
C_{pd} Power dissipation capacitance	No load, $f = 1$ MHz	27	pF



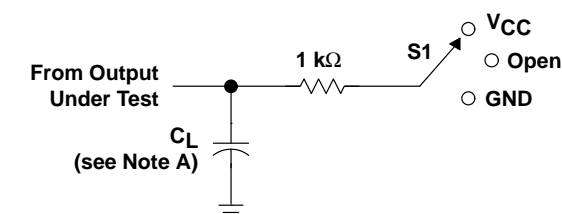
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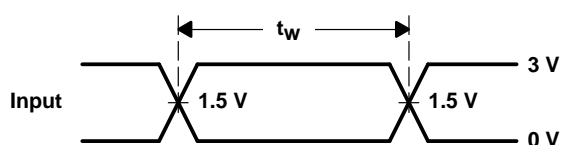
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PARAMETER MEASUREMENT INFORMATION

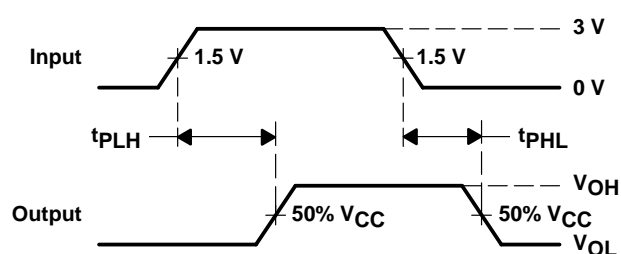


LOAD CIRCUIT

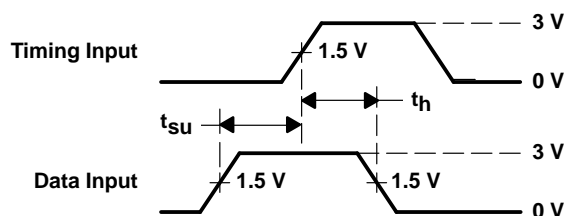
TEST	S1
t _{PLH} /t _{PHL}	Open
t _{PLZ} /t _{PZL}	V _{CC}
t _{PHZ} /t _{PZH}	GND



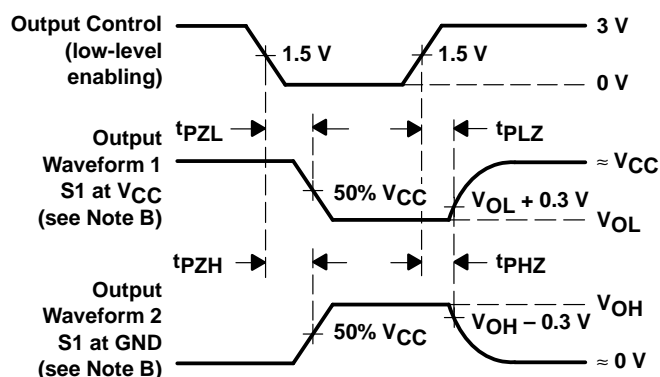
VOLTAGE WAVEFORMS
PULSE DURATION



VOLTAGE WAVEFORMS
DELAY TIMES



VOLTAGE WAVEFORMS
SETUP AND HOLD TIMES



VOLTAGE WAVEFORMS
ENABLE AND DISABLE TIMES

NOTES: A. C_L includes probe and jig capacitance.

B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control.

Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.

C. All input pulses are supplied by generators having the following characteristics: PRR ≤ 1 MHz, Z_O = 50 Ω, t_r = 3 ns, t_f = 3 ns.

D. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms

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